

Searched 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10752675	LEE ET AL.
	Examiner Mehrpour, Naghmeh	Art Unit 2617

Class	SubClass	Date	Examiner
455	432.1	9/21/05	NM
	410		
	435.1		
	436		
713	156		
	158		
	175		
370	331		
	338		
713	150		
Updated		7/11/06	
Updated		9/15/06	
U.S. Patent and Trademark Office		Part of Paper No.:	9/15/06

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
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Notes	Date	Examiner
East	9/21/05	NM
	7/11/06	NM
	9/15/06	NM
Temica Beamer	7/13/06	NM
Trinh Sonny	7/12/06	NM
Nquyen Vo	7/12/06	NM
Inventor searched done in eDAN	9/15/06	NM
U.S. Patent and Trademark Office	Part of Paper No.:	9/15/06

Interference Searched 	Application/Control No.	Applicant(s)/Patent Under Reexamination
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Please see the attachment for interference search			
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